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SAMARA

Superconducting **A**lternative **M**aterials
for **A**ccelerating cavities and
haloscope **R**esonators for **A**xions



Role in the project and Status

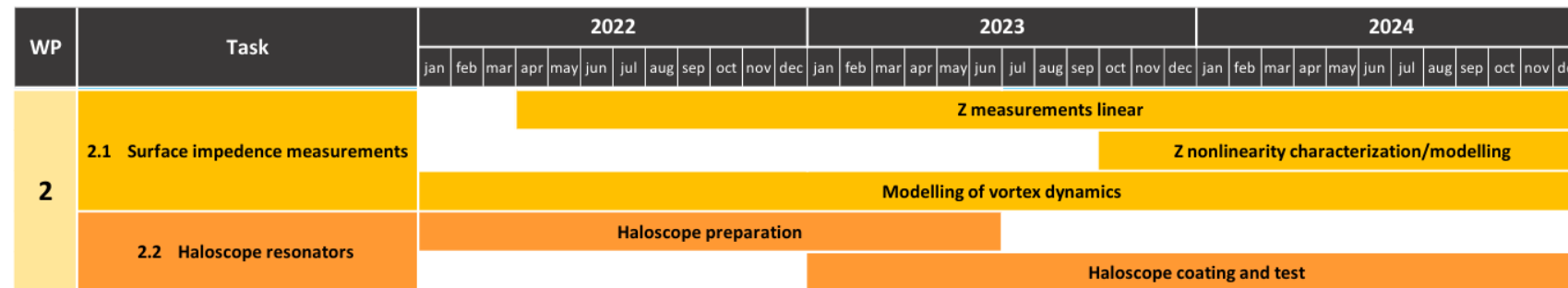
WP2 – SRF in extreme conditions

WP2: SRF in extreme conditions	Task 2.1 Surface impedance measurements	
	Sample coatings: NbTi and Nb ₃ Sn	LNL
	Dielectric-loaded resonators measurements	RM3
	Patterned coplanar waveguide resonator measurements	TO
	Multi-harmonic susceptibility	LNF
	Physical Modelling	RM3, TO
	Nonlinearity studies	TO, RM3
	Task 2.2 Haloscope resonators	
	Haloscope design and production	LNF
	Haloscope deposition	LNL
Haloscope measurement	LNF	

Proposed Milestones 2022

- First surface impedance measurements on
- ✓ **NbTi** and Nb₃Sn films on insulating substrates
 - ΔZ measurements on 2 NbTi samples
 - T range 4-15 K
 - H range <1.2 T (\perp and //)

GANTT



Budget 2022

- ✓ - 500 l LHe acquired ($\approx 1^{\text{st}}$ year budget)
- acquired additional 1.5 k€

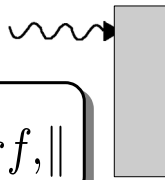
Outline

- The measurand: surface impedance in the mixed state
- The experimental technique
- Measurements & preliminary results

Surface impedance

Surface impedance - introduction

- Electrodynamical response at high frequency: surface impedance

At the surface: 

$$\mathbf{E}_{rf,\parallel} = Z_s \hat{\mathbf{n}} \times \mathbf{H}_{rf,\parallel}$$

$Z_s = R_s + iX_s$
losses + screening

- Z_s : “performance” of microwave cavities

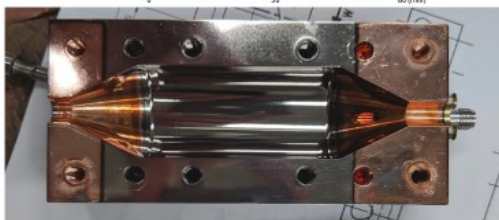
$$Q = \frac{2\pi\nu_0 W}{P_{diss}}$$

quality factor

$\rightarrow \frac{1}{Q} = \frac{R_s}{G}$

dissipation

W: stored energy
P_{diss}: dissipated power
G: geometrical factors
(computed | calibrated)

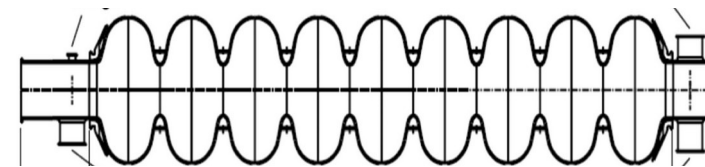


NbTi haloscope

Alesini et al.
Phys. Rev. D 99
101101(R) (2019)

$$R_s(H) \Rightarrow Q \Rightarrow \text{Axion signal}$$

(linear regime)



9-cell TESLA-type
accelerating cavity

H. Padamsee,
Supercond. Sci. Technol. 30,
053003 (2017)

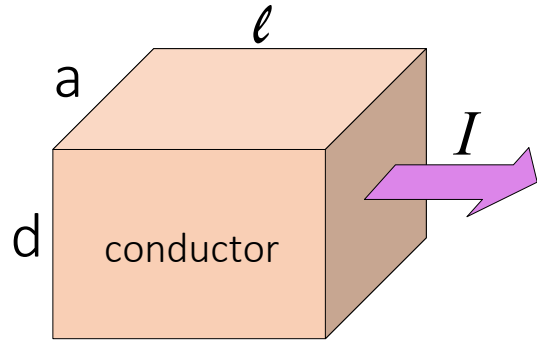
$$R_s(H_{rf}) \Rightarrow Q \Rightarrow E_{acc}$$

(non linear regime)

- Z_s : probe for basic properties \rightarrow input to theory and material engineering

Surface impedance

d.c. regime, normal conductor



Ohm laws

$$P_{diss} = RI^2 = \rho \frac{l}{ad} I^2$$

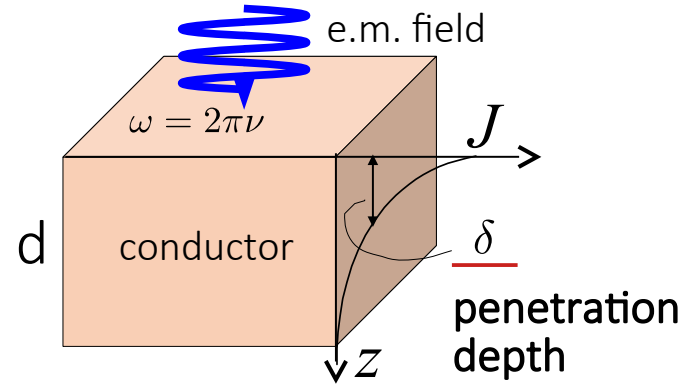
$$\frac{P_{diss}}{\square} = \rho \frac{l}{ad} I^2 \frac{1}{al}$$

$$\frac{P_{diss}}{\square} = R_s J_s^2$$

$$R_s = \frac{\rho}{d} \quad \text{sheet resistance}$$

$$J_s = \frac{I}{a} \quad \text{surface current density}$$

high frequency ν , normal conductor



- $J(z)$ attenuated along **skin depth**:

$$\delta = \sqrt{\frac{2\rho}{\omega\mu_0}}, \quad \rho \text{ real}$$

- surface resistance:

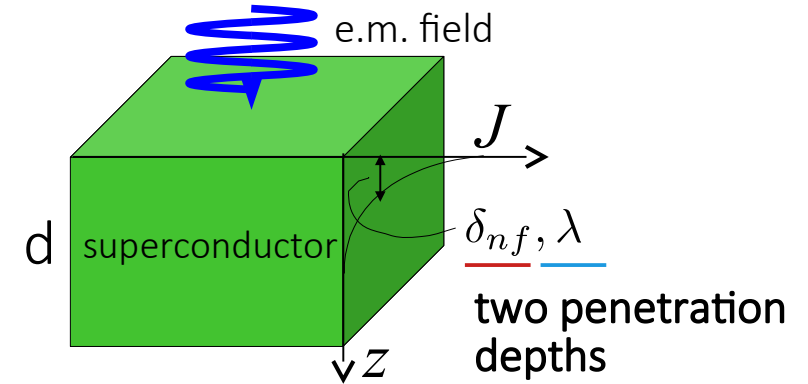
$$R_s = \frac{\rho}{\delta} \quad \text{dissipation}$$

- surface impedance:

$$Z_s = \sqrt{i\omega\mu_0\rho} = R_s + iX_s$$

(bulk limit: $\delta \ll d$)

high frequency, superconductor, $H=0$



- complex ρ , two fluid model:

$$\tilde{\rho}^{-1} = \sigma_{2f} = \sigma_{nf} - i\frac{1}{\omega\mu_0\lambda^2}, \quad \delta_{nf} = \sqrt{\frac{2\rho_{nf}}{\omega\mu_0}} \quad \text{normal fluid skin depth}$$

- (bulk) surface impedance:

$$Z_s = \sqrt{i\omega\mu_0\tilde{\rho}} \quad \lambda \quad \text{London penetration depth}$$

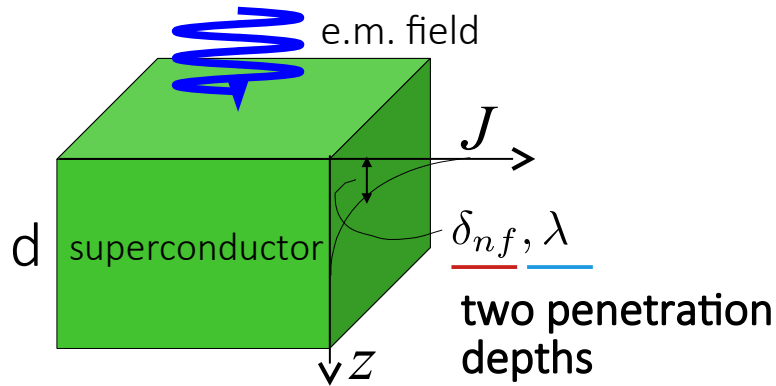
(bulk limit: $(\delta_{nf}, \lambda) \ll d$)

- actual surface resistance for SRF:

$$R_s = \text{Re}(Z_s)_{(BCS)} + R_{res} + R_{fl}$$

Surface impedance in superconductors

high frequency, superconductor, $H=0$



$$\delta_{nf} = \sqrt{\frac{2\rho_{nf}}{\omega\mu_0}} \quad \lambda$$

normal fluid skin depth London penetration depth

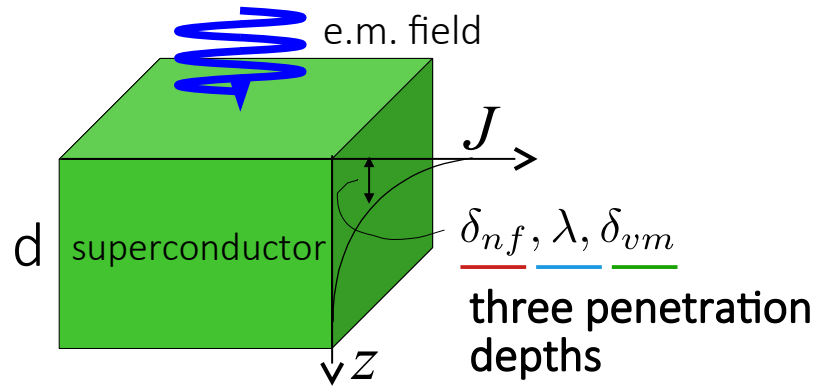
- (bulk) surface impedance:

$$Z_s = \sqrt{i\omega\mu_0\tilde{\rho}}$$

(bulk limit: $(\delta_{nf}, \lambda) \ll d$)

Coffey and Clem, Phys. Rev. Lett. 67 386 (1991)

high frequency, superconductor, mixed state



- complex ρ : two fluid σ_{2f} + vortex motion ρ_{vm}

$$\tilde{\rho} = \frac{\rho_{vm} + i\omega\mu_0\lambda^2}{1 + i\sigma_n\omega\mu_0\lambda^2}$$

- additional penetration depth:

$$\delta_{vm} = \sqrt{\frac{2\rho_{vm}}{\omega\mu_0}}$$

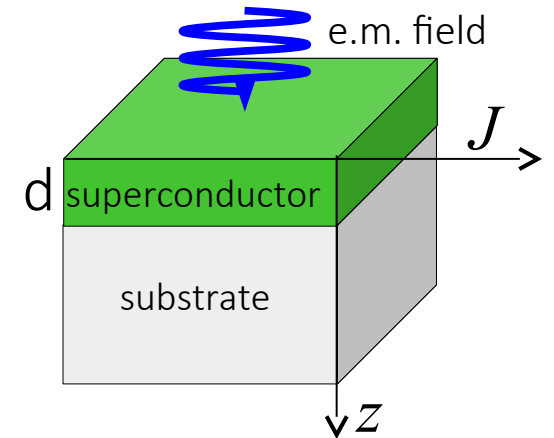
Vortex motion penetration depth

- overall complex penetration depth:

$$\tilde{\lambda}^2 = \frac{\lambda^2 - \frac{i}{2}\delta_{vm}^2}{1 + 2i\frac{\lambda^2}{\delta_{nf}^2}}$$

$$\text{complex interplay} \\ |\tilde{\lambda}| > \lambda$$

finite thickness effects



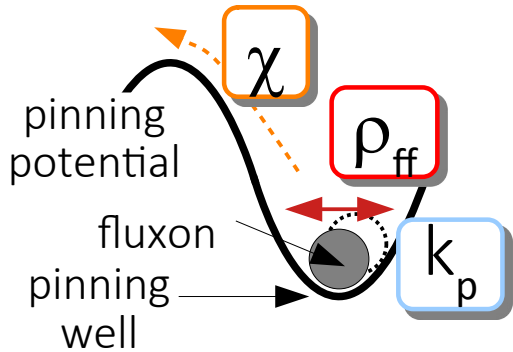
- $d \sim (\delta_{nf}, \lambda, |\delta_{vm}|)$
 \rightarrow rf fields reach the substrate
 \rightarrow **effective** Z_s depends on both SC and substrate

Pompeo et al, IEEE Trans. App. Supercond. 5 8003405 (2019)
 Pompeo et al, I2MTC 2017 Conf. Proceedings

- thin film approx:
 $d \ll (\delta_{nf}, \lambda, |\delta_{vm}|)$
 insulating substrate

$$Z_s = \frac{\tilde{\rho}}{d}$$

High frequency vortex motion response



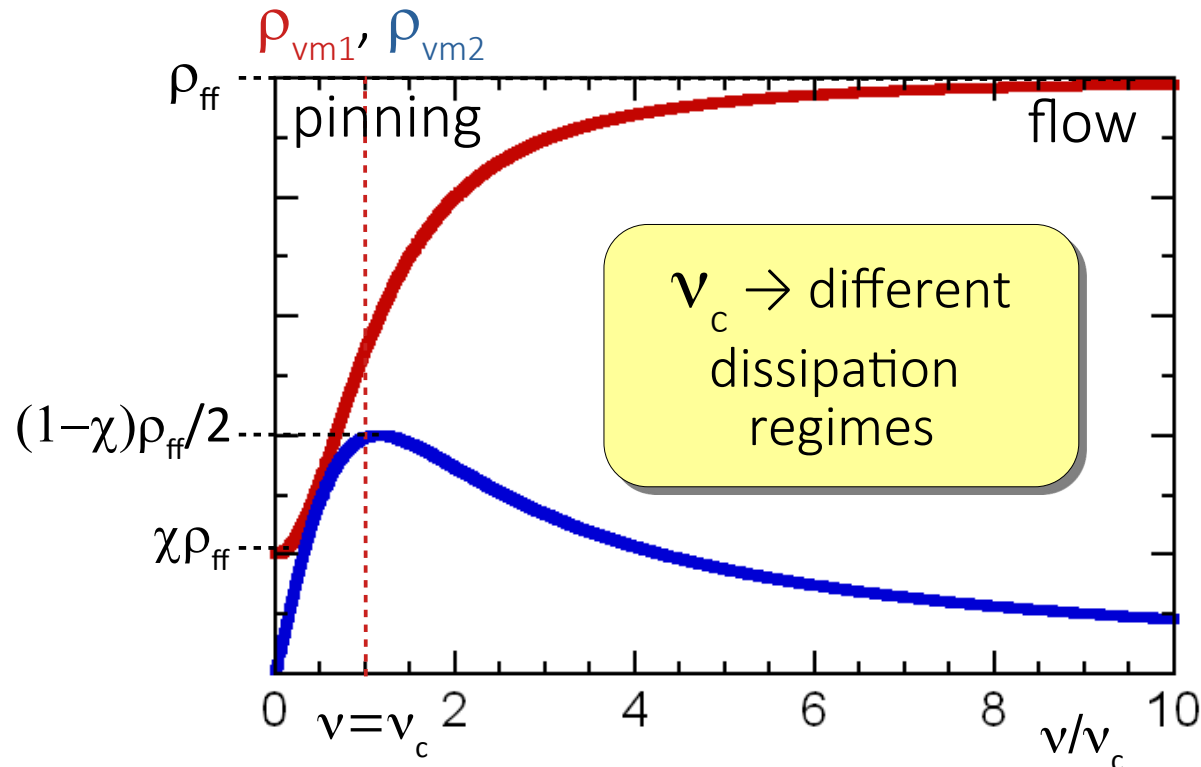
$$\mathbf{J} \times \Phi_0 - \eta \dot{\mathbf{u}} - k_p \mathbf{u} + \mathbf{F}_{thermal} = m \ddot{\mathbf{u}}$$

$$\Rightarrow \mathbf{E}_{rf} = \mathbf{B} \times \dot{\mathbf{u}} \Rightarrow \rho_{vm}$$

$$\rho_{vm} = \rho_{vm1} + i\rho_{vm2} = \rho_{ff} \frac{\chi + i\nu/\nu_c}{1 + i\nu/\nu_c}$$

Many models,
one equation

- Pompeo, Silva, PRB 78 , 094503 (2008)
- Gittleman, Rosenblum PRL 16 734 (1966) No creep
- Coffey, Clem PRL 67 386 (1991) Sinusoidal potential
- Brandt PRL 67 2219 (1991) Thermally relaxing pinning
- Placais et al PRB 54 13083 (1996) Two-modes



flux flow resistivity ρ_{ff}
(viscosity η)

$$\rho_{ff} = \alpha \rho_n \frac{B}{B_{c2}}$$

dissipation

characteristic freq. ν_c
pinning freq. ν_p

$$\nu_{c\chi \rightarrow 0} \rightarrow \nu_p$$

pinning constant k_p

$$k_p = 2\pi\nu_p\eta$$

creep factor χ

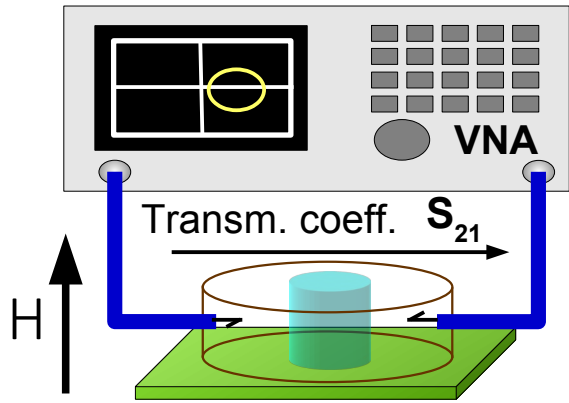
related to pinning barriers heights U_0

$$0 \leq \chi \leq 1$$

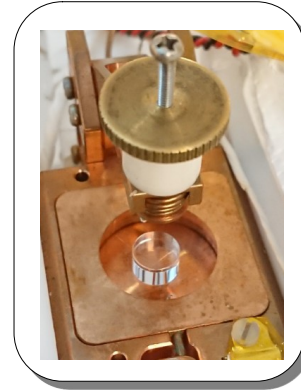
Experimental technique

Measurement technique

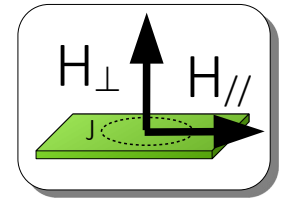
Dielectric-loaded resonator (surface perturbation method).



- dual frequency operation:
 $\nu_1=16.5$ GHz,
 $\nu_2=26.7$ GHz

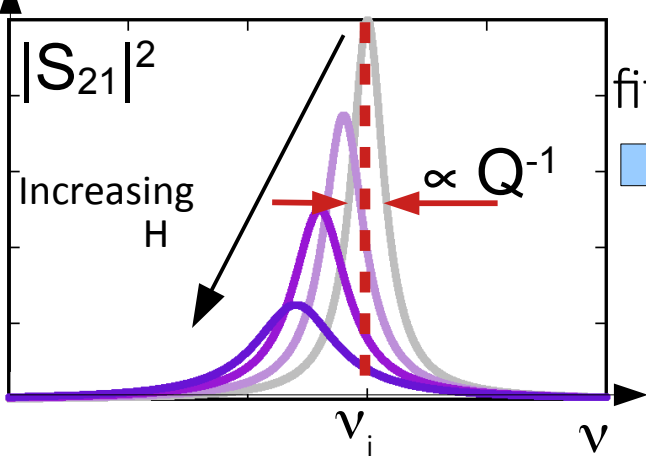


• Probing area
 $\varnothing \leq 20$ mm



- Rotatable H
- $0 < \mu_0 H < 1.2$ T

Frequency sweeps



fit
 Q, ν
 resonator parameters

std. em theory

H-induced variations:

$$\Delta R_s(H) = G \left(\frac{1}{Q(H)} - \frac{1}{Q(0)} \right)$$

$$\Delta X_s(H) = -2G \frac{\nu(H) - \nu(0)}{\nu(0)}$$

2 observables vs many parameters

↳ Multifrequency (rarely performed)

$$\Delta Z_s(H) \rightarrow \rho_{vm}$$

Various limits:

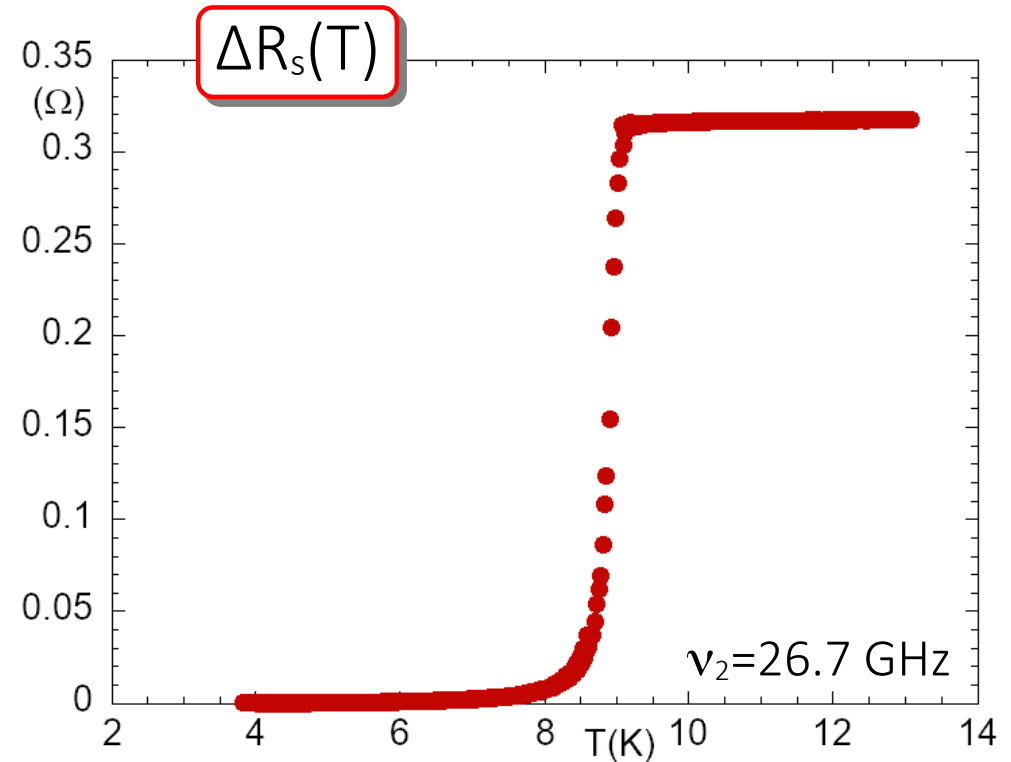
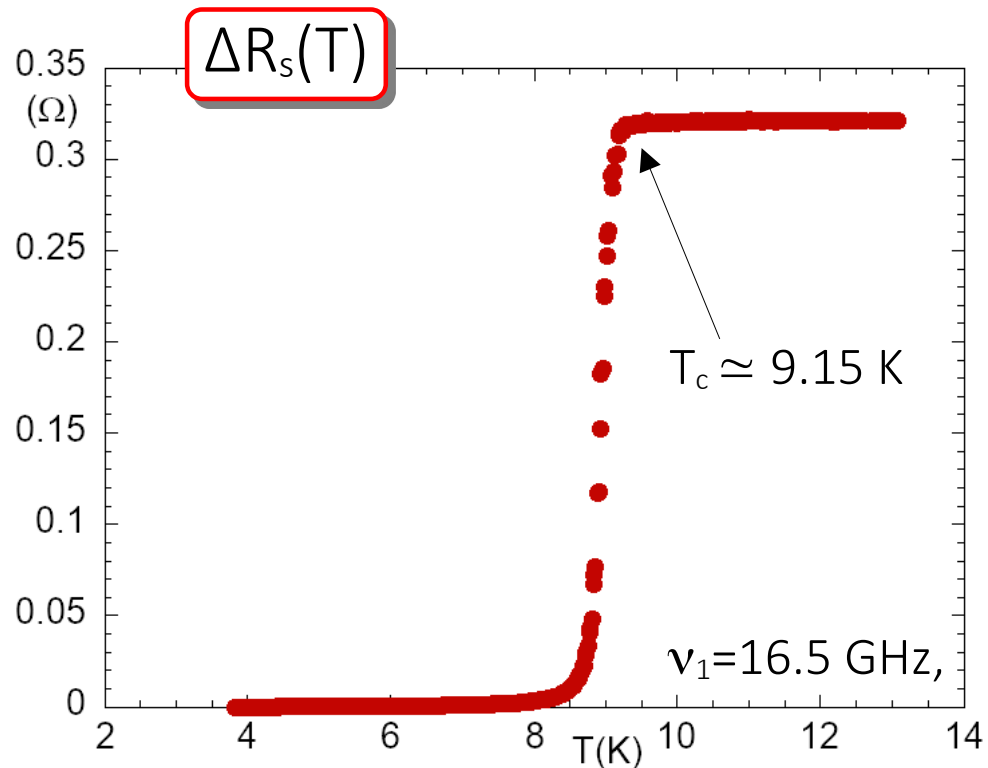
- thin film on insulator $Z_s \propto \rho$
- bulk $Z_s \propto \sqrt{\rho}$
- film on metal & thick film $Z_s(\rho)$

Alimenti et al. Meas. Sci. Technol. 30 065601 (2019)
 Pompeo et al, Measurement 184 109937 (2021)

Measurements and preliminary analysis

Superconducting transition

- Nb₆₀Ti₄₀ films on dielectric ($d \simeq 1.7 \pm 0.2 \mu\text{m}$ thick) - sample 1



$$\Delta R_s = R_s(T) - R_s(T_{\min})$$

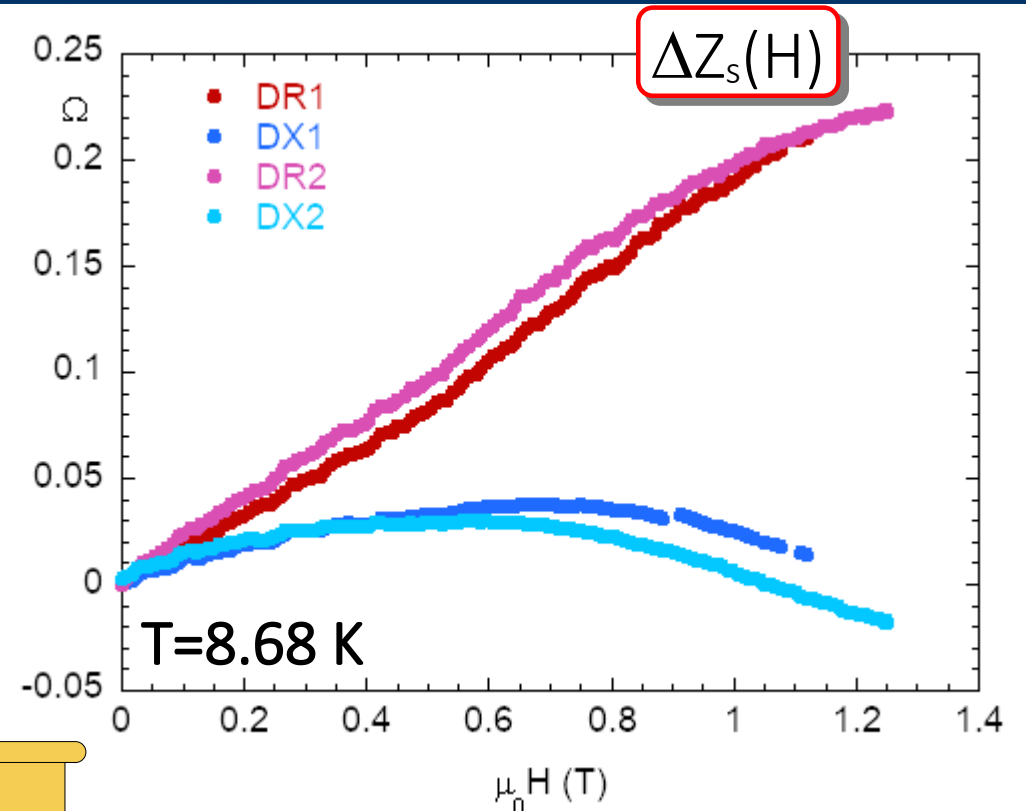
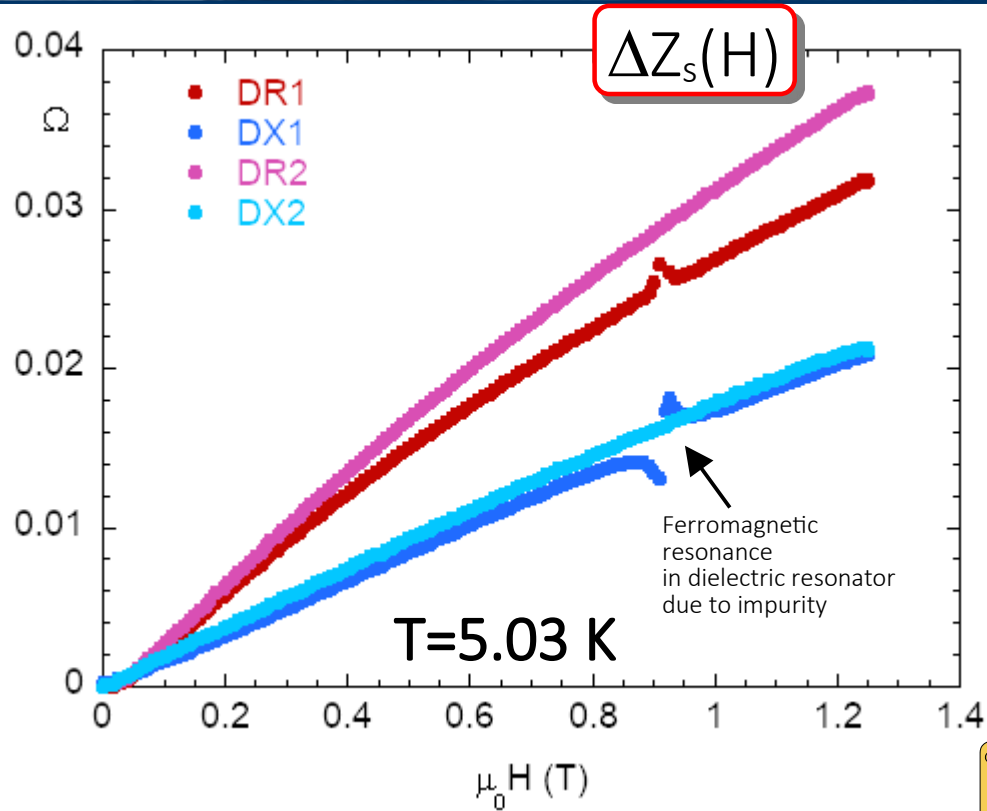
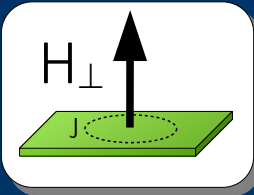
- Normal state resistivity:

$$\rho_n = R_s(T > T_c) \cdot d \simeq 5.4 \cdot 10^{-6} \Omega \cdot m$$

wrt $(4 \div 7) \cdot 10^{-6} \Omega \cdot m$

Benvenuti et al, Fifth Workshop RF Supercond. 1991

$\Delta Z(H)$ at selected T

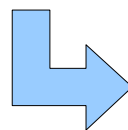


All T : ΔR & ΔX increase with H
 \rightarrow vortex motion

Low T : downward curvature
 \rightarrow possible **bulk regime**

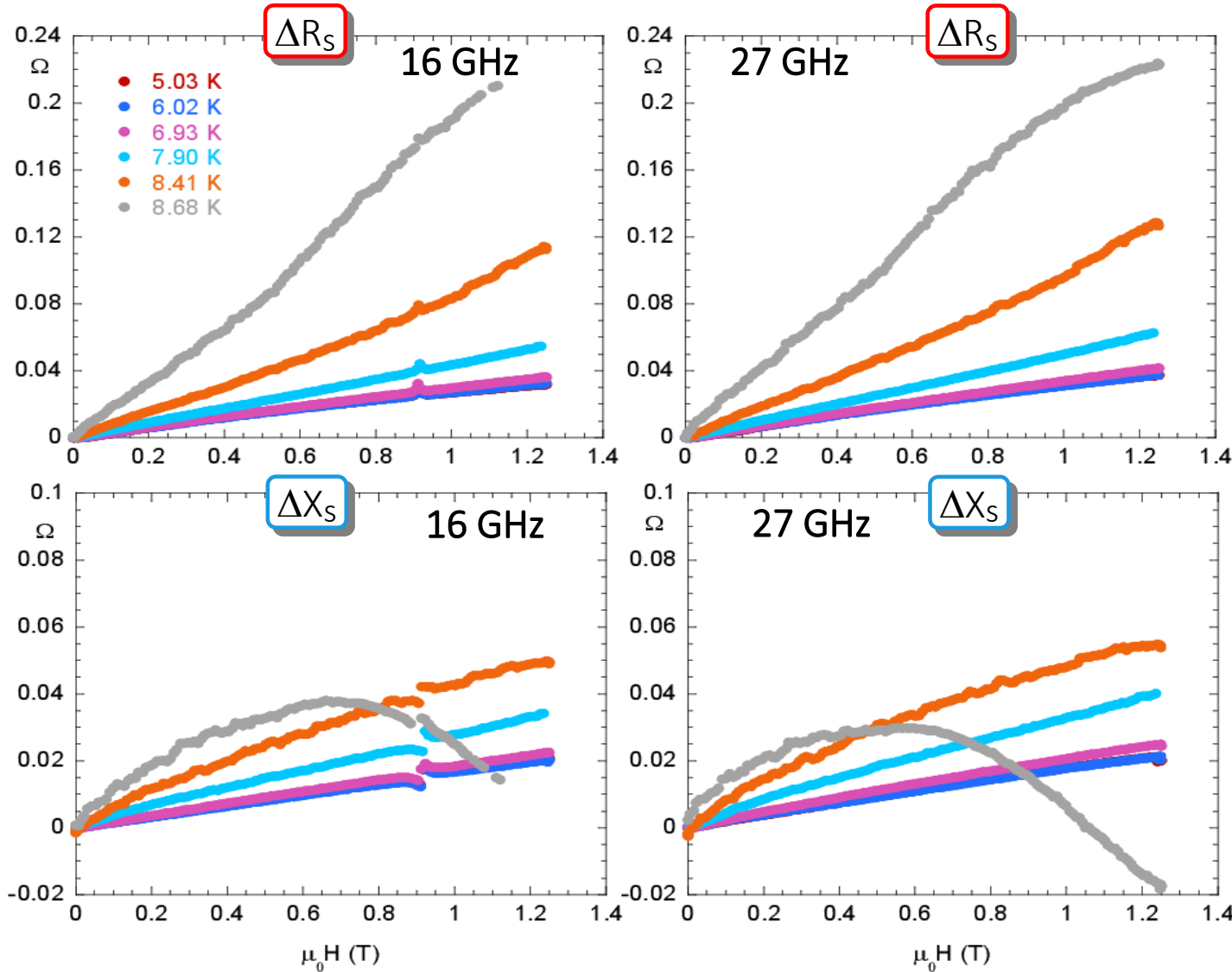
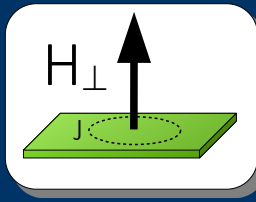
Change in effective regime

Near T_c : $\Delta X < 0$
 \rightarrow e.m. **thin film** & 2-fluids contribution



by nearing $H_{c2}(T) \rightarrow$ thin film regime
 \rightarrow choice of coating thickness in function of (H,T, ν)

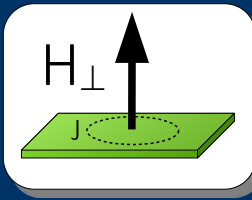
$\Delta Z(H)$ – temperature evolution



● $\Delta R(H)$ curvature changes with T
→ complex electrodynamics
(thermal creep, two fluid,
B-dep. vortex parameters)

Focus on low T

Extraction of vortex parameters



Fit model

- complex resistivity:

$$\tilde{\rho} = \rho_{ff} \frac{1 + i \frac{\nu_p}{\nu}}{1 + \left(\frac{\nu_p}{\nu}\right)^2} + i\omega\mu_0\lambda^2(T)$$

$$\rho_{ff} = \alpha\rho_n \frac{B}{B_{c2}(T)} \quad \lambda(T) = \lambda_0 / (1 - (T/T_c)^4)$$

→ two field independent fit parameters: α, ν_p

Parameters set from other measurements: ρ_n, T_c

Parameters taken from literature: $B_{c2}(0 \text{ K})$

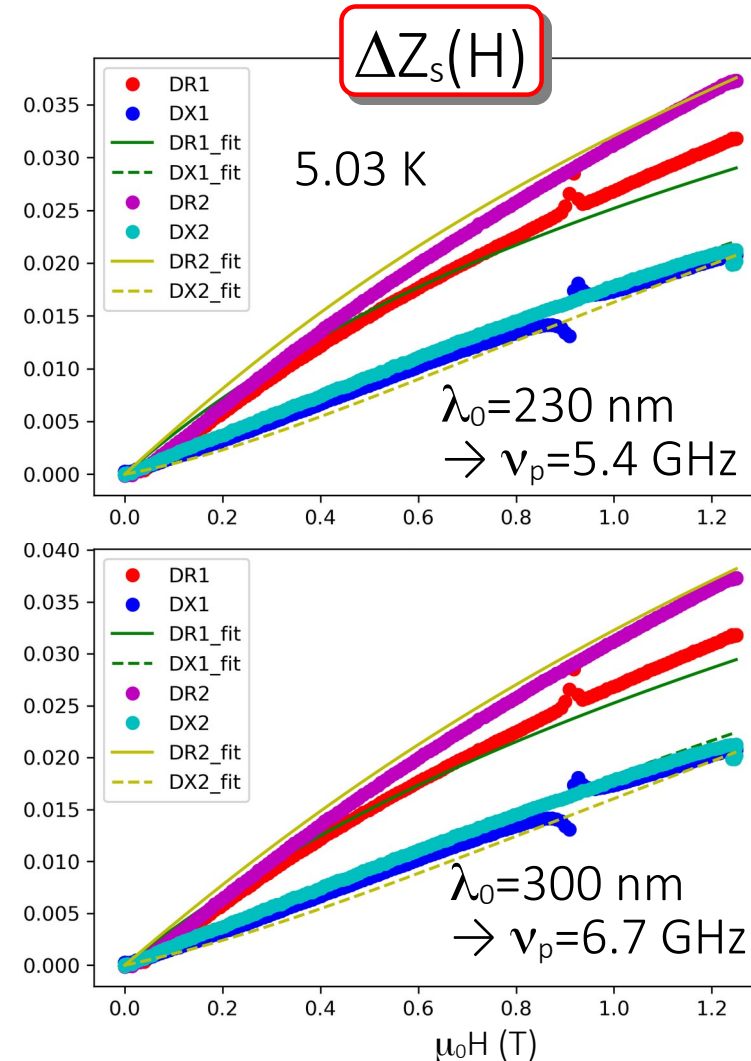
$$\lambda_0 \in [230, 300] \text{ nm}$$

Giordano et al, IEEE Trans. Magn. v. MAG-11 437 (1976)

Benvenuti et al, Fifth Workshop RF Supercond. 1991

- expression for the **effective** surface impedance Z_s

model sensitivity on λ_0



• Robust result
 $\nu_p \sim 6 \text{ GHz}$

- NbTi coated: ✗
 $\nu_p \sim 44 \text{ GHz}$
@ 4.2 K, 0-5 T

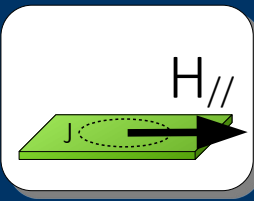
Di Gioacchino et al.
IEEE Trans. Appl. Supercond.
29 3500605 (2019)

(different H orientation)

- Nb₃Sn bulk: ✓
 $\nu_p \sim 7 \text{ GHz}$,
@ 6 K, 2 T

Alimenti et al.
Supercond. Sci. Technol.
34 014003 (2021)

$\Delta Z(H)$ – temperature evolution - $H//ab$

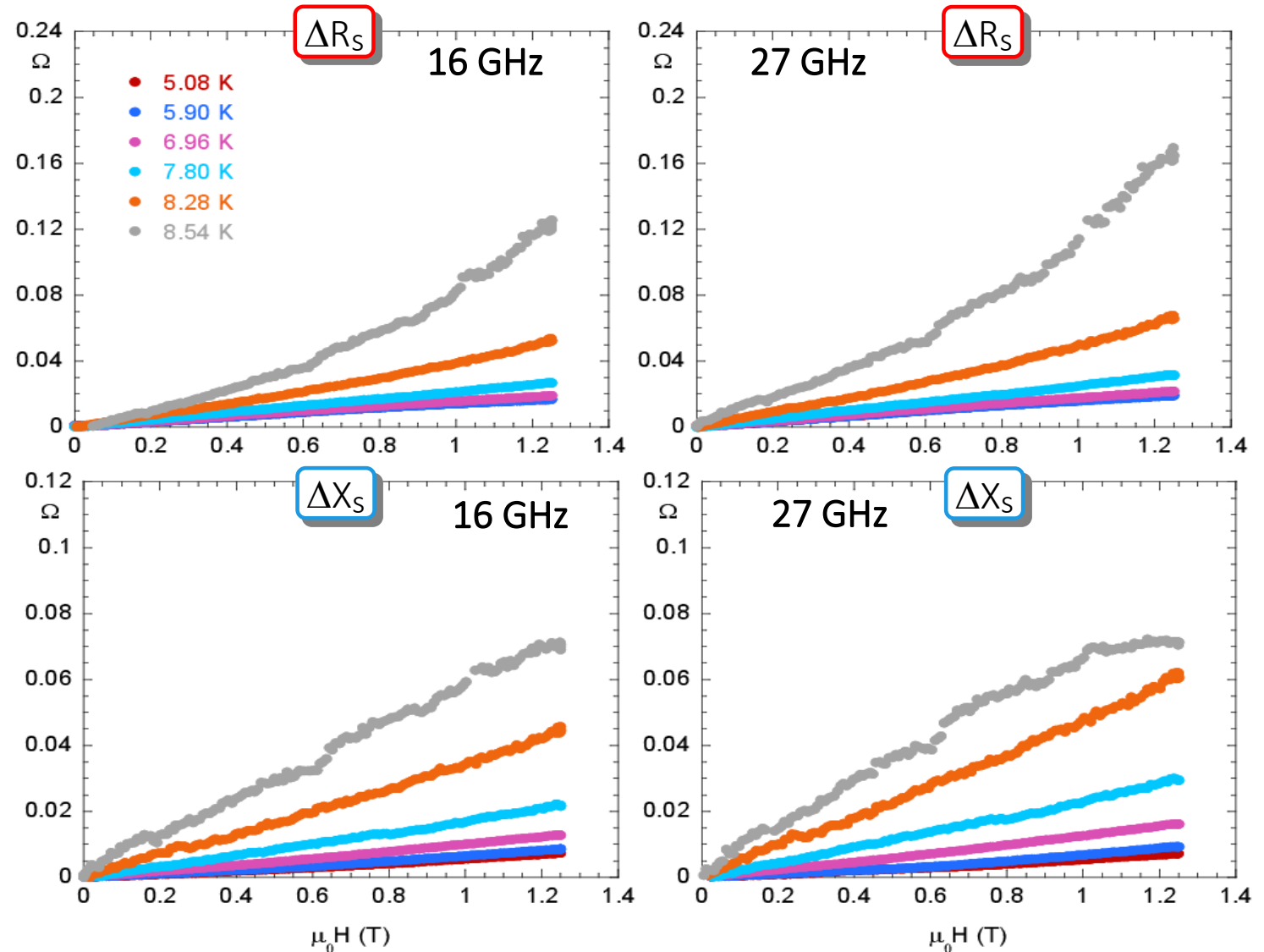


Need for measurements at different H orientations:
- haloscopes: $H // J$

Di Gioacchino et al. IEEE Trans. Supercond. 29 3500605 (2019)
Alesini et al. Phys. Rev. D 99 101101(R) (2019)
Alimenti et al Instruments 6 1 (2022)

- typical dielectric resonator setup:
 $H \perp J$
→ use of rotatable magnet

Preliminary result:
 $v_p \approx 5-10$ GHz



Summary

Preliminary results on NbTi films on insulator at fields < 1.2 T

- Identification of regimes/models for Z_s
- Determination of
 - pinning frequency: $\nu_p \sim 6$ GHz at 5 K
 - change in regimes (bulk vs thin film) \rightarrow coating thickness

Thanks!